



### **Maximum Ratings**

Storage Temperature	
Ambient Temperature with Power Applied	40°C to $+85$ °C
Supply Voltage V <sub>CC</sub>	0.5V to +7.0V
DC Switch Voltage V <sub>S</sub>	0.5V to +7.0V
DC Input Voltage V <sub>IN</sub>	0.5V to +7.0V
DC Output Current V <sub>OUT</sub>	128mA
DC $V_{CC}$ or Ground Current $I_{CC}/I_{GND}$	±100mA
Junction Temperature under Bias (T <sub>J</sub> )	150°C
Junction Lead Temperature (TL)	
(Soldering, 10 seconds)	260°C
ESD (HBM)	5KV
Power Dissipation (PD) @ +85°C	MSOP10 350mW

### Note:

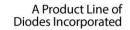
Stresses greater than those listed under MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

**Recommended Operating Conditions** 

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
$V_{CC}$	Operating Voltage	-	1.65	-	5.5	V
$V_{IN}$	Control Input Voltage	-	0	-	$V_{CC}$	V
$V_{S}$	Switch Input Voltage	-	0	-	5.5	V
V <sub>OUT</sub>	Output Voltage	-	0	-	$V_{CC}$	V
$T_A$	Operating Temperature	-	-40	25	85	°C
+ +	Input Rise and Fall Time	Control Input $V_{CC} = 2.7V$ to $3.6V$	0	-	10	ns/V
$t_r, t_f$	input Kise and Fair Time	Control Input $V_{CC} = 4.5V$ to $5.5V$	0	-	5	ns/V

Note: Control input must be held HIGH or LOW; it must not float.







### **DC** Electrical Characteristics

 $(T_A = -40$  °C to 85 °C, unless otherwise noted.)

Symbol	Parameter	<b>Test Conditions</b>	Supply Voltage	Min.	Тур.	Max.	Units	
$V_{IAR}$	Analog Input Signal Range	-	$V_{CC}$	0	-	$V_{CC}$	V	
		$I_{Ax}=100\text{mA}, V_{nBx}=0V$		-	0.7	1.1	Ω	
		$I_{Ax}=100 \text{mA}, V_{nBx}=2.4 \text{V}$	$V_{CC}=4.5V$	-	0.6	1.0		
		$I_{Ax} = 100 \text{mA}, V_{nBx} = 4.5 \text{V}$		-	0.8	1.2		
		$I_{Ax}=100mA$ , $V_{nBx}=0V$	V <sub>CC</sub> =3.0V	-	0.8	1.3	Ω	
$R_{ON}$	ON Resistance (1)	$I_{Ax} = 100 \text{mA}, V_{nBx} = 3.0 \text{V}$	V CC=3.0 V	-	0.9	1.9		
		$I_{Ax}=100mA$ , $V_{nBx}=0V$	V <sub>CC</sub> =2.3V	-	1.0	1.5	Ω	
		$I_{Ax} = 100 \text{mA}, V_{nBx} = 2.3 \text{V}$	▼ CC=2.5 ▼	-	1.2	1.8	32	
		$I_{Ax}=100\text{mA}, V_{nBx}=0V$	V <sub>CC</sub> =1.65V	-	1.3	1.9	Ω	
		$I_{Ax} = 100 \text{mA}, V_{nBx} = 1.65 \text{V}$	VCC=1.03 V	-	2.0	2.8	32	
		$I_{Ax} = 100 \text{mA}, V_{nBx} = 3.15 \text{V}$	$V_{CC}=4.5V$	-	0.01	0.12		
A D	ON Resistance Match	$I_{Ax}=100 \text{mA}, V_{nBx}=2.1 \text{V}$	$V_{CC}=3.0V$	-	0.02	-	Ω	
$\Delta R_{\rm ON}$	Between Channels (1,2,3)	$I_{Ax}=100 \text{mA}, V_{nBx}=1.6 \text{V}$	$V_{CC}=2.3V$	-	0.03	-	1 12	
		$I_{Ax}=100 \text{mA}, V_{nBx}=1.15 \text{V}$	V <sub>CC</sub> =1.65V	-	0.03	-	1	
R <sub>ONF</sub> ON Resistance Flatness (		$I_{Ax}=100 \text{mA}, V_{nBx}=0 \text{V}, 2.4 \text{V}, 4.5 \text{V}$	V <sub>CC</sub> =4.5V	-	0.2	0.4	Ω	
	ON Pasistanca Flatness (1,2,4)	$I_{Ax}=100\text{mA}, V_{nBx}=0V,1.5V,3.3V$	V <sub>CC</sub> =3.3V	-	0.2	0.4		
	On Resistance Platness	$I_{Ax}=100\text{mA}, V_{nBx}=0V,1.1V,2.5V$	$V_{CC}=2.5V$	-	0.4	0.6		
		$I_{Ax}=100 \text{mA}, V_{nBx}=0 \text{V}, 0.7 \text{V}, 1.8 \text{V}$	$V_{CC}=1.8V$	-	1.0	1.4		
		$V_{CC} = 1.65V$	0.9	-	-			
		Logic High Level	$V_{CC}=2.3V$	1.0	-	-	V	
$V_{IH}$	Input High Voltage		$V_{CC}=3.0V$	1.1	-	-		
			$V_{CC}=4.2V$	1.2	-	-		
			$V_{\rm CC}=5.5V$	1.3	-	-		
		tage Logic Low Level	$V_{CC} = 1.65V$	-	-	0.6		
	Input Low Voltage		$V_{CC}=2.3V$	-	-	0.6	V	
$V_{ m IL}$			$V_{CC}=3.0V$	-	-	0.6		
			$V_{CC}=4.2V$	-	-	0.8		
			$V_{CC}=5.5V$	-	-	0.8		
I <sub>OFF(Bn)</sub>	Source Off Leakage Current	$V_{Ax} = 1V/4.5V, V_{nBx} = 1V/4.5V$	$V_{CC}=3.0V$	-20	-	+20	nA	
$I_{ON(A,\;Bn)}$	Channel On Leakage Current	-	V <sub>CC</sub> =1.65V to 5.5V	-40	-	+40	nA	
T	Quiescent Supply Current	All Channels ON or OFF,	V <sub>CC</sub> =3.6V	-	0.002	0.1	μA	
$I_{CC}$		$V_{nBx}=V_{CC}$ and GND, $I_{OUT}=0A$	V <sub>CC</sub> =5.5V	-	0.002	0.1	μΑ	
$I_{CCT}$	Increase in I <sub>CC</sub> per Input	Channel Input at 2.7V	V <sub>CC</sub> =4.3V	-	0.2	10.0	μA	

### Notes:

- 1. Measured by voltage drop between A and B pins at the indicated current through the device. ON resistance is determined by the lower of the voltages on two ports (Ax or nBx) x = 0 or 1, n = 0 or 1.
- 2. Parameter is characterized but not tested in production.
- 3.  $\Delta R_{ON}$  =  $R_{ON}$  max  $R_{ON}$  min. measured at identical  $V_{CC}$ , temperature and voltage levels.
- 4. Flatness is defined as difference between maximum and minimum value of ON resistance over the specified range of conditions.

## Capacitance (1)

Symbol	Parameter	Test Conditions	Supply Voltage	Temp (℃)	Min.	Тур.	Max.	Units
$C_{IN}$	Control Input				-	3.5	-	
C <sub>IO-B</sub>	For Bn Port, Switch OFF	$f = 1 \text{ MHz}$ $V_0$	$V_{CC} = 5.0V$	$T_A = 25$ °C	-	15.0	-	pF
C <sub>IOA-ON</sub>	For An Port, Switch ON				-	34.0	-	

### Notes

 $1. \ Capacitance \ is \ characterized \ but \ not \ tested \ in \ production$ 





# Switch and AC Characteristics $^{(1)}$

Parameter	Description	Test Conditions	Supply Voltage	Min	Тур	Max	Units
t	Break Before	See Figure 2	$V_{CC} = 2.7V \text{ to } 3.6V$	-	10	-	
t BBM	Make Time	See 1 iguie 2	$V_{CC} = 4.5V \text{ to } 5.5V$	-	6	-	
<b>t</b>	Turn on Time	See Figure 1	$V_{CC} = 2.7V \text{ to } 3.6V$	-	16	-	ns
$t_{ON}$	Turn on Time	See Figure 1	$V_{CC} = 4.5V \text{ to } 5.5V$	-	12	-	118
+	Turn off Time	Coo Eiguno 1	$V_{CC} = 2.7V \text{ to } 3.6V$	-	8	-	
$\mathbf{t}_{\mathrm{OFF}}$	Turn on Time	See Figure 1	$V_{\rm CC} = 4.5 \text{V to } 5.5 \text{V}$	-	5	-	
0	Charge	$C_L = 1nF, V_{GEN} = 0V,$	$V_{CC} = 5.0V$	-	35	-	рC
Q	Injection $R_{GEN} = 0.52$ . See Figure 3 $V_{CC} = 3.3V$	$R_{GEN}$ = $0\Omega$ . See Figure 3	-	25	-	рС	
OIRR	Off Isolation <sup>(2)</sup>	$R_L$ =50 $\Omega$ , $V_{GEN}$ =0 $V$ , $R_{GEN}$ =0 $\Omega$ , $f$ =1MHz. See Figure 4	$V_{CC} = 1.65 \text{V to } 5.5 \text{V}$	-	-70	-	dB
X <sub>TALK</sub>	Crosstalk Isolation	f=1MHz, See Figure 5	$V_{CC} = 1.65 \text{V to } 5.5 \text{V}$	-	-70	-	
f3dB	-3dB Bandwidth	See Figure 8	$V_{CC} = 1.65 \text{V to } 5.5 \text{V}$	-	150	-	MHz
T <sub>HD</sub>	Total Harmonic Distortion	$R_L$ =600 $\Omega$ , $V_{IN}$ =0.5 $V$ pp, f=20 $H$ z to 20 $k$ Hz See Figure 9	$V_{CC} = 2.7V \text{ to } 4.2V$	-	0.015	-	%

### **Notes:**

- 1. Guaranteed by design.
- 2. Off Isolation = 20 Log $_{10}$  [ $V_{nBx}/V_{Ax}$ ] and is measured in dB.



## **Test Circuits and Timing Diagrams**

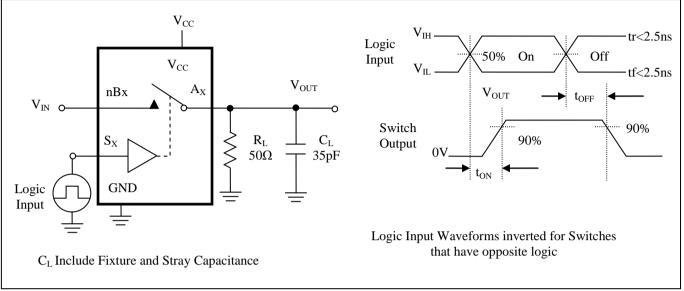


Figure 1. Turn ON/OFF Timing

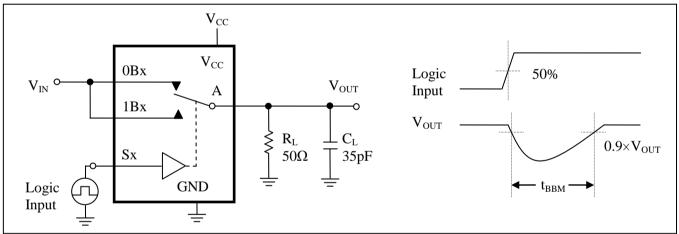


Figure 2. Break Before Make Interval Timing

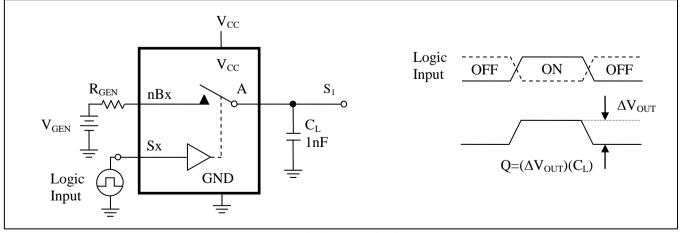


Figure 3. Charge Injection Test



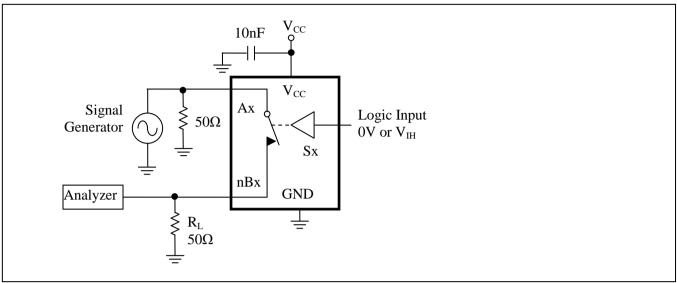


Figure 4. Off Isolation

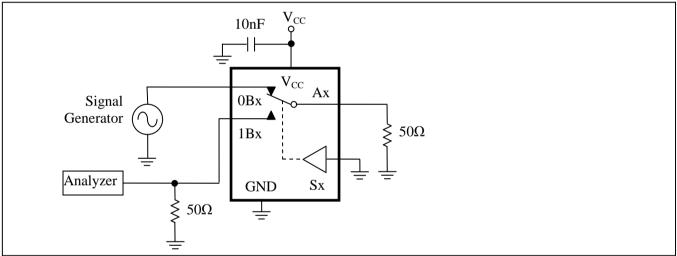


Figure 5. Crosstalk

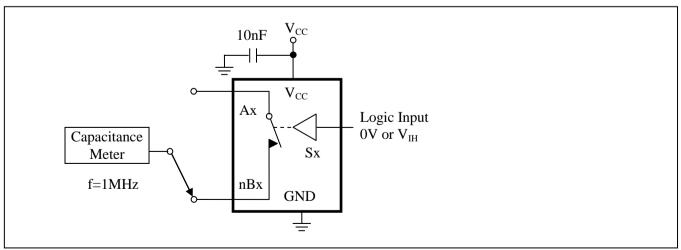


Figure 6. Channel Off Capacitance



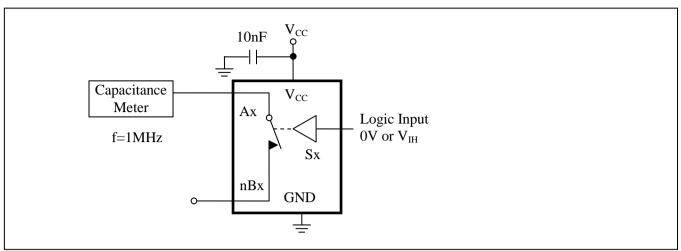


Figure 7. Channel On Capacitance

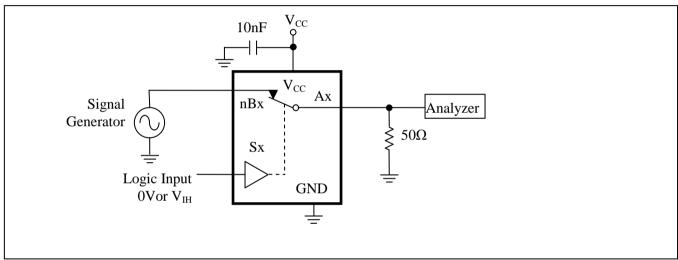


Figure 8. Bandwidth

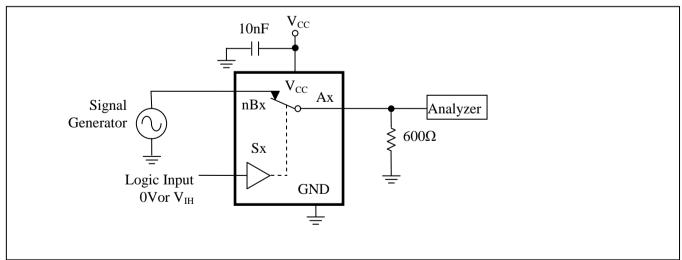


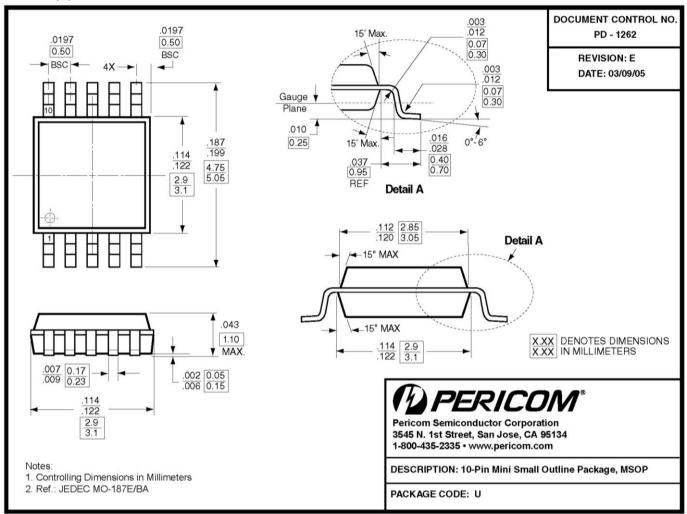
Figure 9. Harmonic Distortion





### **Packaging Mechanical**

10-MSOP (U)



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### **Ordering Information**

Part Number	Package Code	Package Description
PI5A23159UEX	U	10-Pin, Mini Small Outline Package (MSOP)

### **Notes:**

- EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant. All applicable RoHS exemptions applied.
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